

<b>Notice of References Cited</b>	Application/Control No. 10/655,373		Applicant(s)/Patent Under Reexamination DILUOFFO ET AL.	
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	C	US-2003/0149576	08-2003	Sunyich, Steven L.	705/1
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	E	US-6,414,635	07-2002	Stewart et al.	342/457
	F	US-6,199,762	03-2001	Hohle, William	235/492
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